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Front Matter: Volume 8362

, "Front Matter: Volume 8362," Proc. SPIE 8362, Passive and Active Millimeter-Wave Imaging XV, 836201 (14 June 2012); doi: 10.1117/12.979018

Event: SPIE Defense, Security, and Sensing, 2012, Baltimore, Maryland, United States

PROCEEDINGS OF SPIE

Passive and Active Millimeter-Wave Imaging XV

**David A. Wikner
Arttu R. Luukanen**
Editors

**26 April 2012
Baltimore, Maryland, United States**

Sponsored and Published by
SPIE

Volume 8362

Proceedings of SPIE, 0277-786X, v. 8362

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

Passive and Active Millimeter-Wave Imaging XV, edited by David A. Wikner, Arttu R. Luukanen,
Proc. of SPIE Vol. 8362, 836201 · © 2012 SPIE · CCC code: 0277-786X/12/\$18 · doi: 10.1117/12.979018

Proc. of SPIE Vol. 8362 836201-1

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Author(s), "Title of Paper," in *Passive and Active Millimeter-Wave Imaging XV*, edited by David A. Wikner, Arttu R. Luukanen, Proceedings of SPIE Vol. 8362 (SPIE, Bellingham, WA, 2012) Article CID Number.

ISSN 0277-786X

ISBN 9780819490407

Published by

SPIE

P.O. Box 10, Bellingham, Washington 98227-0010 USA

Telephone +1 360 676 3290 (Pacific Time) · Fax +1 360 647 1445

SPIE.org

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